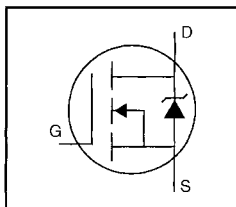


- Dynamic  $dv/dt$  Rating
- Repetitive Avalanche Rated
- Surface Mount (IRLR120)
- Straight Lead (IRLU120)
- Available in Tape & Reel
- Logic-Level Gate Drive
- $R_{DS(on)}$  Specified at  $V_{GS}=4V$  &  $5V$



$$V_{DSS} = 100V$$

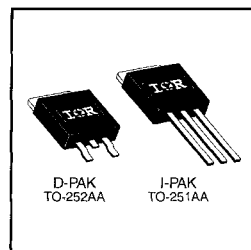
$$R_{DS(on)} = 0.27\Omega$$

$$I_D = 7.7A$$

### Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The D-Pak is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 watts are possible in typical surface mount applications.



DATA  
SHEETS

### Absolute Maximum Ratings

|                             | Parameter                                  | Max.                  | Units |
|-----------------------------|--------------------------------------------|-----------------------|-------|
| $I_D$ @ $T_C = 25^\circ C$  | Continuous Drain Current, $V_{GS}$ @ 5.0 V | 7.7                   | A     |
| $I_D$ @ $T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS}$ @ 5.0 V | 4.9                   |       |
| $I_{DM}$                    | Pulsed Drain Current ①                     | 31                    |       |
| $P_D$ @ $T_C = 25^\circ C$  | Power Dissipation                          | 42                    | W     |
| $P_D$ @ $T_A = 25^\circ C$  | Power Dissipation (PCB Mount)**            | 2.5                   |       |
|                             | Linear Derating Factor                     | 0.33                  | W/°C  |
|                             | Linear Derating Factor (PCB Mount)**       | 0.020                 |       |
| $V_{GS}$                    | Gate-to-Source Voltage                     | $\pm 10$              | V     |
| $E_{AS}$                    | Single Pulse Avalanche Energy ②            | 210                   | mJ    |
| $I_{AR}$                    | Avalanche Current ①                        | 7.7                   | A     |
| $E_{AR}$                    | Repetitive Avalanche Energy ①              | 4.2                   | mJ    |
| $dv/dt$                     | Peak Diode Recovery $dv/dt$ ③              | 5.5                   | V/ns  |
| $T_J, T_{STG}$              | Junction and Storage Temperature Range     | -55 to +150           | °C    |
|                             | Soldering Temperature, for 10 seconds      | 260 (1.6mm from case) |       |

### Thermal Resistance

|                 | Parameter                         | Min. | Typ. | Max. | Units |
|-----------------|-----------------------------------|------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case                  | —    | —    | 3.0  | °C/W  |
| $R_{\theta JA}$ | Junction-to-Ambient (PCB mount)** | —    | —    | 50   |       |
| $R_{\theta JA}$ | Junction-to-Ambient               | —    | —    | 110  |       |

\*\* When mounted on 1" square PCB (FR-4 or G-10 Material).

For recommended footprint and soldering techniques refer to application note #AN-994.

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                                 | Parameter                            | Min. | Typ. | Max. | Units               | Test Conditions                                                     |
|---------------------------------|--------------------------------------|------|------|------|---------------------|---------------------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 100  | —    | —    | V                   | $V_{GS}=0V$ , $I_D=250\mu A$                                        |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.13 | —    | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}$ , $I_D=1mA$                         |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —    | 0.27 | $\Omega$            | $V_{GS}=5.0V$ , $I_D=4.6A$ ④                                        |
|                                 |                                      | —    | —    | 0.38 |                     | $V_{GS}=4.0V$ , $I_D=3.9A$ ④                                        |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 1.0  | —    | 2.0  | V                   | $V_{DS}=V_{GS}$ , $I_D=250\mu A$                                    |
| $g_{fs}$                        | Forward Transconductance             | 4.4  | —    | —    | S                   | $V_{DS}=50V$ , $I_D=4.6A$ ④                                         |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 25   | $\mu A$             | $V_{DS}=100V$ , $V_{GS}=0V$                                         |
|                                 |                                      | —    | —    | 250  |                     | $V_{DS}=80V$ , $V_{GS}=0V$ , $T_J=125^\circ\text{C}$                |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA                  | $V_{GS}=10V$                                                        |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100 |                     | $V_{GS}=-10V$                                                       |
| $Q_g$                           | Total Gate Charge                    | —    | —    | 12   | nC                  | $I_D=9.2A$                                                          |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | —    | 3.0  |                     | $V_{DS}=80V$                                                        |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | —    | 7.1  |                     | $V_{GS}=5.0V$ See Fig. 6 and 13 ④                                   |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 9.8  | —    | ns                  | $V_{DD}=50V$                                                        |
| $t_r$                           | Rise Time                            | —    | 64   | —    |                     | $I_D=9.2A$                                                          |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 21   | —    |                     | $R_G=9.0\Omega$                                                     |
| $t_f$                           | Fall Time                            | —    | 27   | —    |                     | $R_D=5.2\Omega$ See Figure 10 ④                                     |
| $L_D$                           | Internal Drain Inductance            | —    | 4.5  | —    | nH                  | Between lead, 6 mm (0.25in.) from package and center of die contact |
| $L_S$                           | Internal Source Inductance           | —    | 7.5  | —    |                     |                                                                     |
| $C_{iss}$                       | Input Capacitance                    | —    | 490  | —    | pF                  | $V_{GS}=0V$                                                         |
| $C_{oss}$                       | Output Capacitance                   | —    | 150  | —    |                     | $V_{DS}=25V$                                                        |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 30   | —    |                     | $f=1.0MHz$ See Figure 5                                             |



## Source-Drain Ratings and Characteristics

|          | Parameter                              | Min.                                                                      | Typ. | Max. | Units   | Test Conditions                                                |
|----------|----------------------------------------|---------------------------------------------------------------------------|------|------|---------|----------------------------------------------------------------|
| $I_S$    | Continuous Source Current (Body Diode) | —                                                                         | —    | 7.7  | A       | MOSFET symbol showing the integral reverse p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —                                                                         | —    | 31   |         |                                                                |
| $V_{SD}$ | Diode Forward Voltage                  | —                                                                         | —    | 2.5  | V       | $T_J=25^\circ\text{C}$ , $I_S=7.7A$ , $V_{GS}=0V$ ④            |
| $t_{rr}$ | Reverse Recovery Time                  | —                                                                         | 110  | 140  | ns      | $T_J=25^\circ\text{C}$ , $I_F=9.2A$                            |
| $Q_{rr}$ | Reverse Recovery Charge                | —                                                                         | 0.80 | 1.0  | $\mu C$ | $di/dt=100A/\mu s$ ④                                           |
| $t_{on}$ | Forward Turn-On Time                   | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ ) |      |      |         |                                                                |

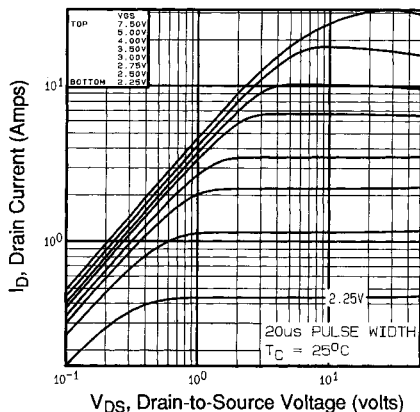
Notes:

① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)

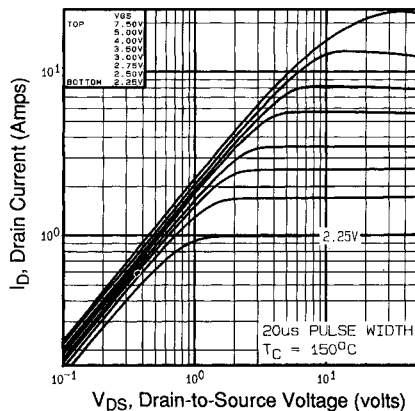
③  $I_{SD} \leq 9.2A$ ,  $di/dt \leq 110A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 150^\circ\text{C}$

②  $V_{DD}=25V$ , starting  $T_J=25^\circ\text{C}$ ,  $L=5.3mH$ ,  $R_G=25\Omega$ ,  $I_{AS}=7.7A$  (See Figure 12)

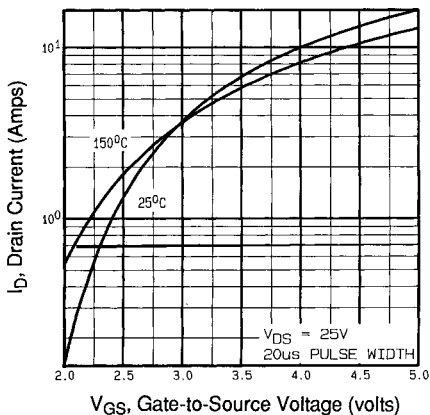
④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .



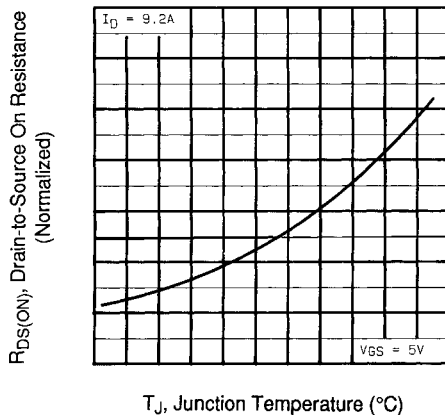
**Fig 1.** Typical Output Characteristics,  
 $T_C = 25^\circ\text{C}$



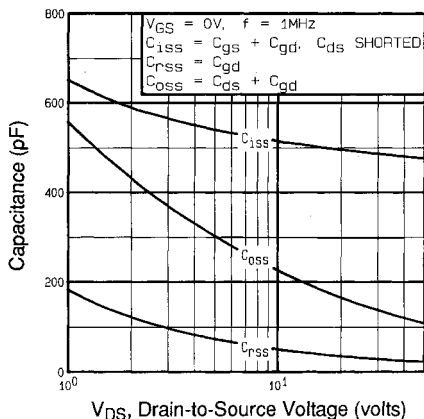
**Fig 2.** Typical Output Characteristics,  
 $T_C = 150^\circ\text{C}$



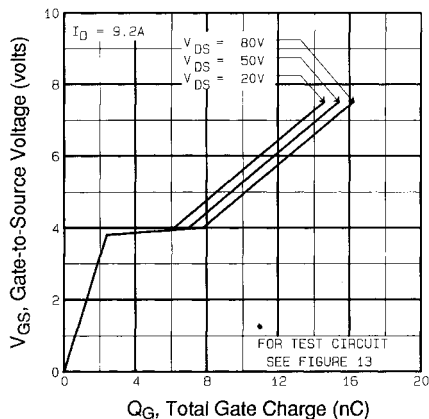
**Fig 3.** Typical Transfer Characteristics



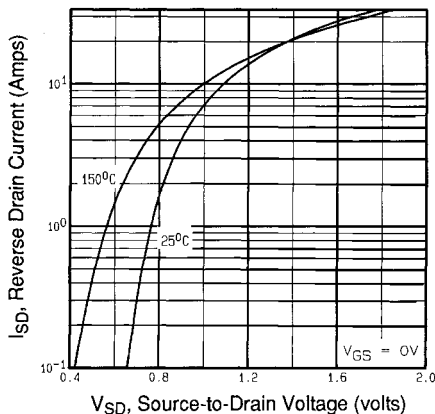
**Fig 4.** Normalized On-Resistance  
Vs. Temperature



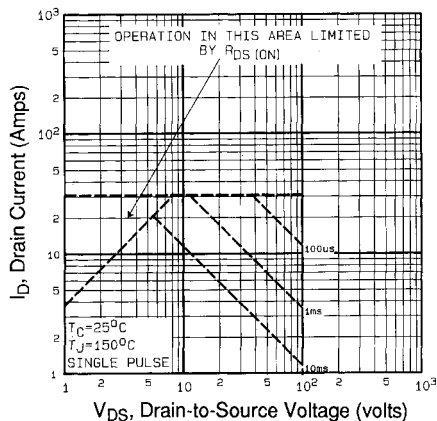
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



**Fig 7.** Typical Source-Drain Diode Forward Voltage



**Fig 8.** Maximum Safe Operating Area

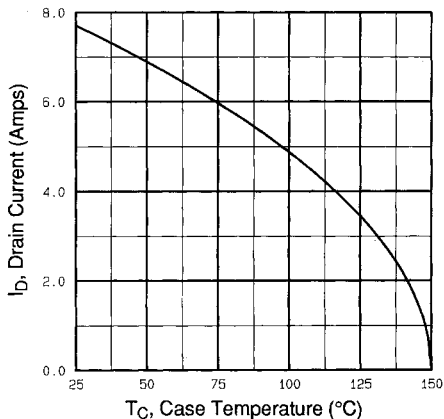


Fig 9. Maximum Drain Current Vs. Case Temperature

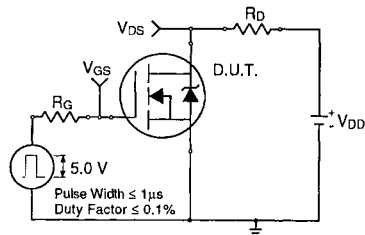


Fig 10a. Switching Time Test Circuit

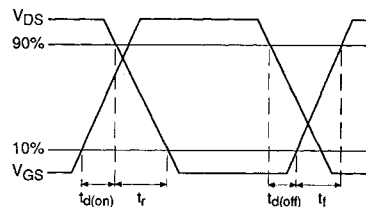


Fig 10b. Switching Time Waveforms

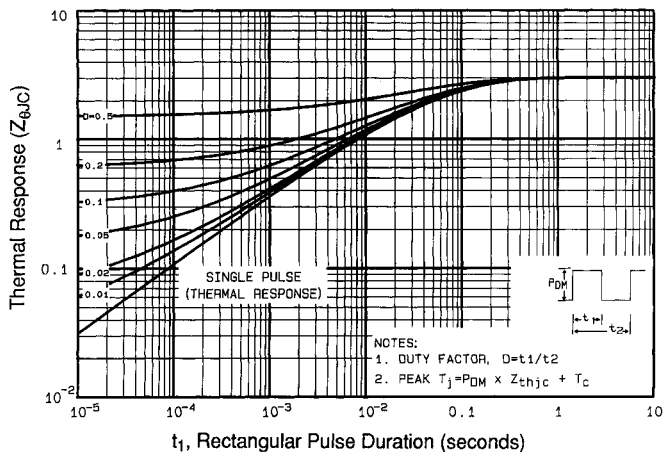
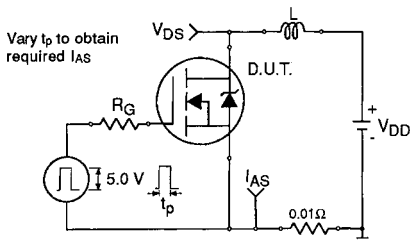
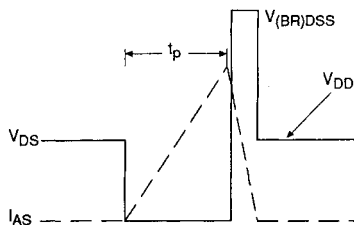


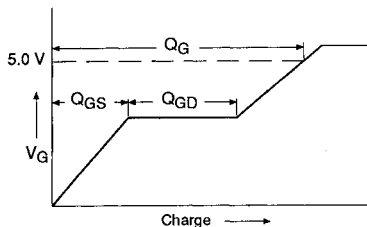
Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



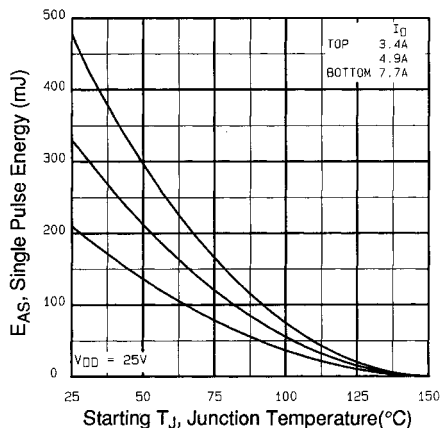
**Fig 12a.** Unclamped Inductive Test Circuit



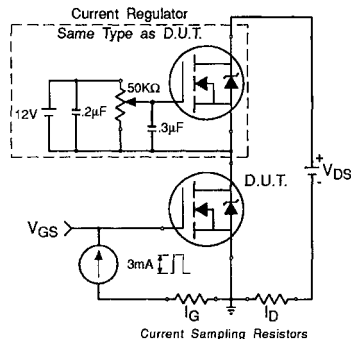
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 13a.** Basic Gate Charge Waveform



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 13b.** Gate Charge Test Circuit

**Appendix A:** Figure 14, Peak Diode Recovery  $dv/dt$  Test Circuit – See page 1505

**Appendix B:** Package Outline Mechanical Drawing – See pages 1512, 1513

**Appendix C:** Part Marking Information – See page 1518

**Appendix D:** Tape & Reel Information – See page 1523